

Ultra-Fast Streaming Camera Platform for Scientific Applications

M. Caselle, S. Chilingaryan, A. Herth, A. Kopmann, U. Stevanovic, M. Vogelgesang, M. Balzer, M. Weber

IPE - Institute for Data Processing and Electronics

Introduction: Synchrotron-based X-ray computed tomography (CT) is a method for a non-destructive investigation of materials. Three-dimensional image of internal structure can be rapidly observed by using two-dimensional detector. A prototype of a high-speed visible light camera based on the commercial CMOS sensor with an embedded processing implemented in the FPGA will be presented. The camera has achieved a frame rate of 340 frames/s with 2.2 Mpixel @ 10bits and a data rate up to 1GB/s. A novel architecture for a self-event trigger signal has been implemented to increase the original frame rate in the range of several kilohertz and, also, to reduce the amount of the received data. Selected applications from life sciences and materials research underline the high potential of this high-speed camera in a hard X-ray micro-imaging approach.

1. Ultra Fast X-ray imaging of scientific processes with On-line assessment and data-driven process control

The ANKA synchrotron radiation source is located at the Karlsruhe Institute of Technology (KIT) in Germany. A novel concept of ultra-fast and micro-imaging X-ray computer tomography experiment station will be installed on the dedicated beam-line. The project 'Ultra Fast X-ray imaging of scientific processes with On-line assessment and data-driven process control' (UFO) aims to develop the next generation of X-ray computer tomography stations optimized to perform 3D and 4D X-ray imaging.

UFO goal are:

Radioscopy with Spatio-temporal micro-resolution
Time-resolved micro-tomography

(4) on-line feedback loop for sample manipulations and optical system.

Sample set-up

X-ray beam line | Storage | Sto

Readout board

Peltier cell (camera cooling)

CMOSIS sensor

Optical system

Optical system

Sample

Sample

Sample

Sample

Sample

Sample

Sample

Sample

Sample

Somical system

Sample

Sample

Somical system

Sample

Sample

Somical system

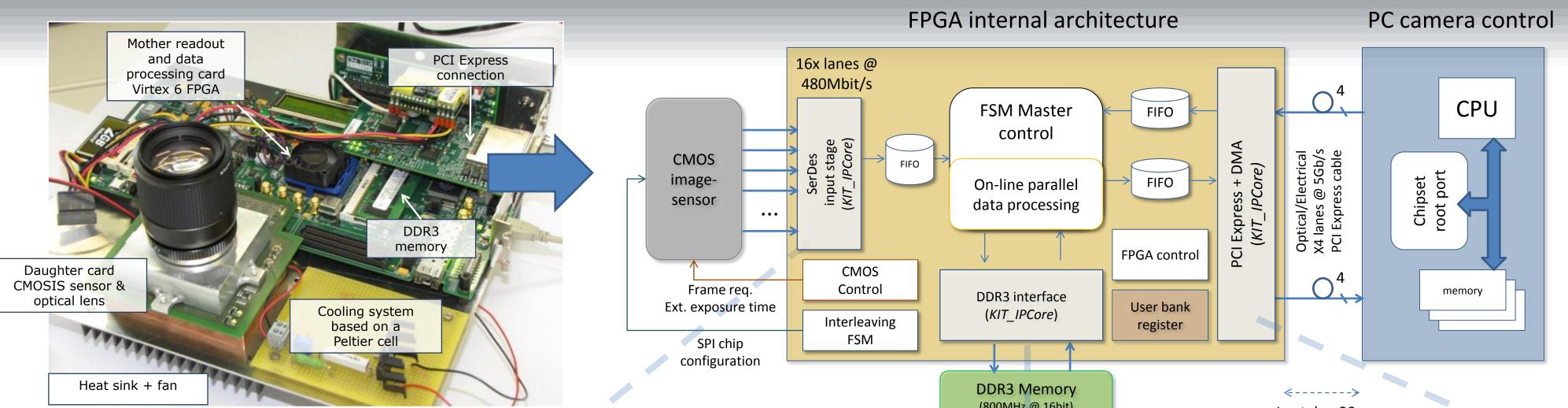
Sample

X-ray fast radiography acquired with the camera prototype described

The camera prototype was successfully tested in ANKA with a moderate X-ray flux density.

The novel concepts employed in the UFO experiment station are: (1) Smart high data throughput camera with a (2) fast optical data link based on PCI Express GEN2. (3) GPU server and on-line data processing and evaluation for accelerating the 3D data reconstruction processing. The speed-up, for the first time, will enable a real-time image processing that will use 2D and 3D image reconstruction for an in the micrometers range.

2. First prototype of the smart high data throughput visible light camera for ultra fast X-ray micro-imaging



The main features, implemented and tested, include:

Fully configurable camera, full access at the pixel parameters in order to adapt the pixel response at any experiment condition.

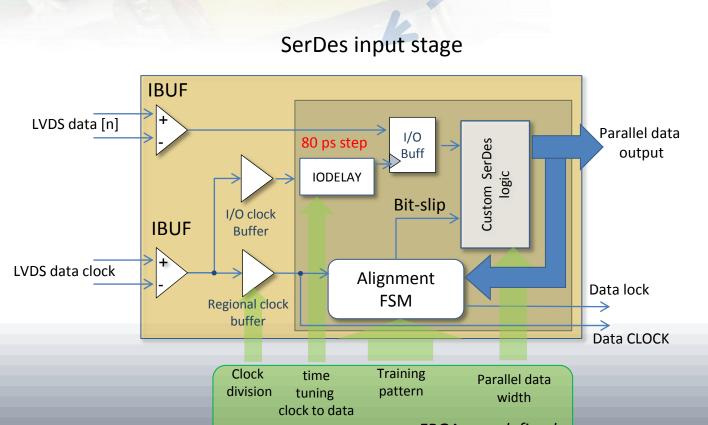
Full streaming data acquisition architecture, continuous data acquisition without dead readout time.

On-line image-based self-event trigger architecture (Fast reject) and Region-Of-Interest readout strategy, intelligent selection of the frame Region-Of-Interest for reducing the amount of output data and, in the same time, to significantly increase the camera frame-rate.

Easily expendable to any available CMOS-image sensor, flexible FPGA architecture easily adapted to any CMOS-image sensor devices.

Three Intellectual Property (IP) logic cores have been developed in KIT

DDR3 memory device interface



A SerDes input stage operating up to 800MHz width a

reconfigurable parallel data width up to 16bit.

Data_in [0..N]

WR_EN
Clock_in

Clock_usr
Read_en
DDR Busy
Loop back
block address_rd pointer
block address_wr pointer

Data_out [0..M]
Data_valid
Clock_out

A DDR3 memory interface operating at 800MHz. The architecture
is able to work in both half and full-duplex modes with a bandwidth

of **51Gb/s** and of **25 Gb/s** respectively.

Data out [0..63]
Data valid
Busy_logic
Clock_out
Data in [0..63]
WR_EN
Back-pressure
Clock_in
Data out [0..63]
WR-Control
packet FSMs
WR-Control
packet FSMs
FPGA temp. &
Voltage control
volt

Performance achieved with a standard PC

Simultaneous write and read operations

64 128 256 512 1024 2048 4096 8192 16384 32768

Packet size (Byte)

Readout chain performance

(PC memory system – DMA – DDR3 device)

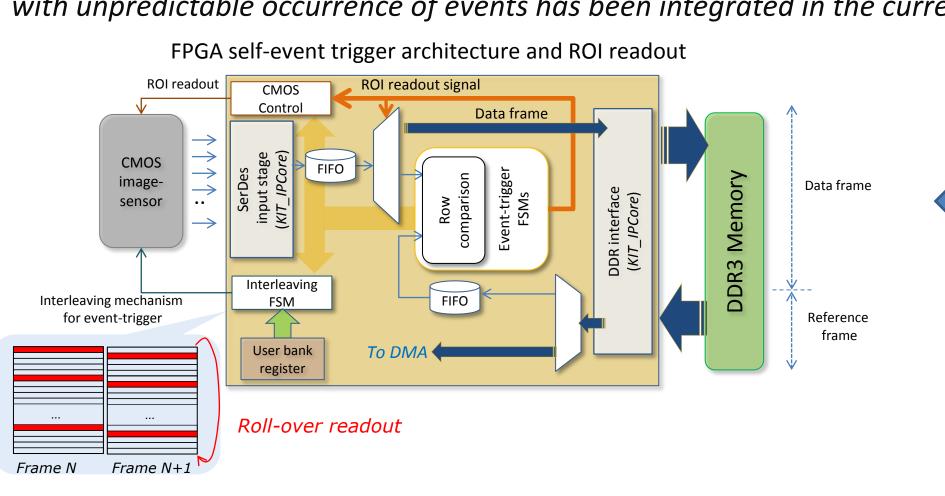
Readout chain performance

A PCI Express GEN2 with theoretical bandwidth 20Gb/s combined with a Bus Master DMA (Direct Memory Access) architecture to fully benefit from the high PCI Express link.

A bandwidth of 16 Gb/s in both directions has achieved with the GPU-server. The bandwidth of 16Gbit/s is only limited by the current FPGA speed-grade.

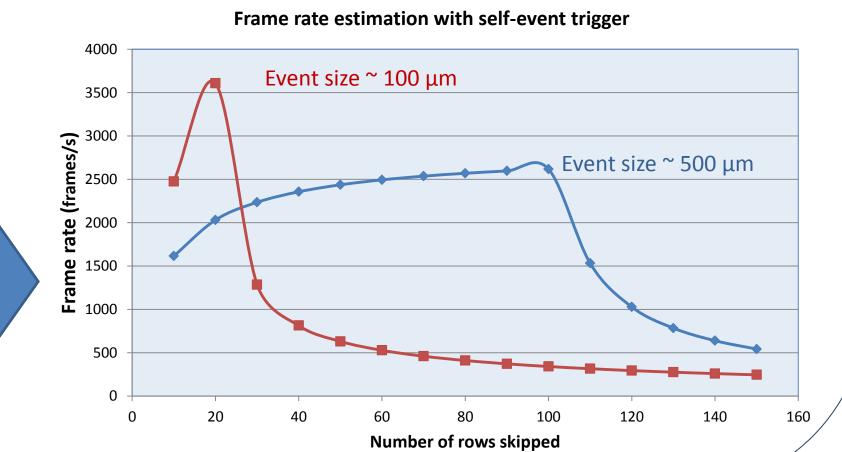
3. Self-event trigger (fast reject) and an intelligent region-of-interest readout

Fast processes which can not be controlled by external signals require a data recording at a high frame rate. Unpredictable physical events could be lost or partially acquired during this limited observation time. **The intelligent image-based self-trigger** for applications with unpredictable occurrence of events has been integrated in the current camera.



Performance: The intelligent Region-Of-Interest readout combined with the self-event trigger (Fast Reject) allows to keep a *high-spatial and time resolution* and the *full point of view of the scene*. This method allows to increase **up to factor 10** the original CMOS-image sensor frame rate.

Self-event trigger and Region-Of-Interest readout architecture

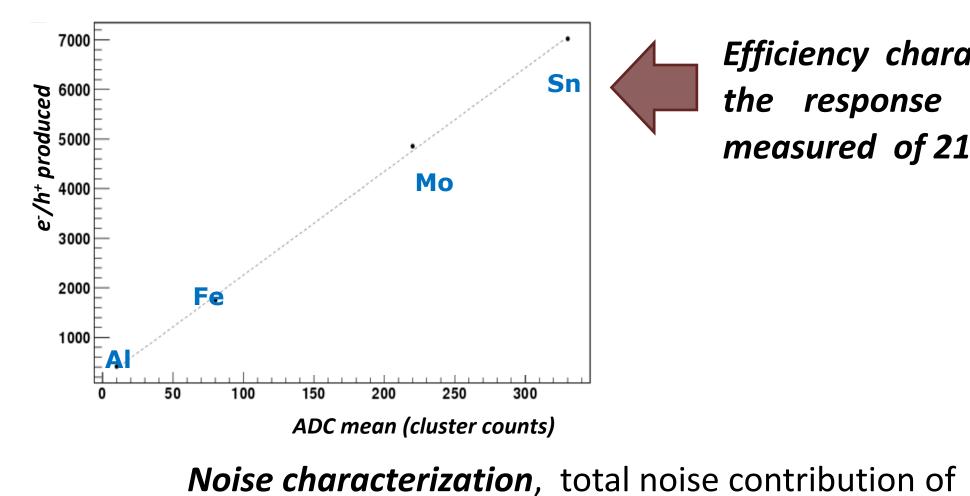


Camera characterization & adaptation at

experiment conditions

The limited density of the photon flux in the synchrotron light source application sets the fundamental limit on image sensor performance in the high frame rate acquisition (short integration time). The temporal noise components are dominant in these conditions. A full programmable camera is a key point for an adaptive camera setting at the different X-ray experiment conditions.

the **87 e⁻/s @14°C**



Efficiency characterization shows an excellent linearity of the response of the CMOS-sensor. Conversion factor measured of 21 e⁻/LSB.

Total dark noise vs. integration time

Total dark noise vs. integration time

Stopped Stopped

Default settings @ 14°C Setting 2 @ 14°C

Frames are acquired at full-speed with 100µs integration time with lower illumination level for default and settings 2 respectively.